

<b>Notice of References Cited</b>	Application/Control No. 10/586,568		Applicant(s)/Patent Under Reexamination ABE ET AL.	
	Examiner DAVID S. WARREN		Art Unit 2837	Page 1 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,240,099 A	03-1966	IRONS DALE M	84/464R
*	B	US-3,869,699 A	03-1975	Haller et al.	367/197
*	C	US-4,185,276 A	01-1980	Benson, Robert G.	340/815.46
*	D	US-4,945,806 A	08-1990	Merrill, Jr., Raymond	84/645
*	E	US-5,070,399 A	12-1991	Martel, Alain	381/56
*	F	US-5,083,064 A	01-1992	Jones, Sr., Charles W.	315/294
*	G	US-5,191,319 A	03-1993	Kiltz, Richard M.	345/73
*	H	US-5,402,702 A	04-1995	Hata, Shuji	84/464R
*	I	US-5,461,188 A	10-1995	Drago et al.	84/600
*	J	US-5,769,527 A	06-1998	Taylor et al.	362/85
*	K	US-2002/0154787 A1	10-2002	Rice et al.	381/124
*	L	US-2004/0139842 A1	07-2004	Brenner et al.	084/477.00R
*	M	US-2004/0123727 A1	07-2004	Hales, Steve	084/645

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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	U	
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<b>Notice of References Cited</b>	Application/Control No. 10/586,568		Applicant(s)/Patent Under Reexamination ABE ET AL.	
	Examiner DAVID S. WARREN		Art Unit 2837	Page 2 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,827,464 B2	12-2004	Koren et al.	362/96
*	B	US-2005/0204899 A1	09-2005	Cheng et al.	084/464.00A
*	C	US-2005/0219842 A1	10-2005	Chornenky, T. E.	362/252
*	D	US-2005/0288159 A1	12-2005	Tackett, Joseph A.	482/084
*	E	US-2005/0272475 A1	12-2005	Hahn, Dong-Yeop	455/566
*	F	US-2006/0027080 A1	02-2006	Schultz, Charles P.	084/613
*	G	US-2006/0027081 A1	02-2006	Chang et al.	084/645
*	H	US-7,071,403 B2	07-2006	Chang, Jen-Chun	84/645
*	I	US-2006/0236845 A1	10-2006	Kilkis, Siir	084/600
*	J	US-2006/0291212 A1	12-2006	Forsman et al.	362/276
*	K	US-7,183,481 B2	02-2007	Hales, Steve Alex	84/645
*	L	US-7,228,190 B2	06-2007	Dowling et al.	700/94
*	M	US-2007/0199432 A1	08-2007	Abe et al.	084/645

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	Examiner DAVID S. WARREN		Art Unit 2837	Page 3 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0041217 A1	02-2008	Knudsen, Craig	084/464.00R
*	B	US-7,344,276 B2	03-2008	Chornenky, Todd Eric	362/252
*	C	US-7,394,010 B2	07-2008	Nishibori et al.	84/464A
*	D	US-7,394,012 B2	07-2008	Schultz, Charles P.	84/615
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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